



Docket No.: 5417-0104PUS1
(PATENT)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:
Hiroto NAKAMURA

Confirmation No: 8592

International Application No.: PCT/JP02/04123

Application No.: 10/512,065

Art Unit: 2829

Filed: October 21, 2004

Examiner: Nguyen, Trung Q

For: ELECTRONIC DEVICE TESTING
APPARATUS

AMENDMENT UNDER 37 C.F.R. 1.114

June 24, 2008

MS Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

INTRODUCTORY COMMENTS

In response to the Office Action dated March 25, 2008, the following amendments and remarks are respectfully submitted in connection with the above-identified application.

The present amendment includes changes to the **Claims** and **Remarks**.

A Request for Continued Examination (RCE) is being filed concurrently with this Reply.



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